Improving the accuracy of novel materials screening: growing defect-tolerant photovoltaic absorbers

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Background: Materials Search and Bil₃

- We have proposed a materials screening methodology focusing on transport in addition to optical properties [1]
- We computationally screen for "proxy" properties that enable high lifetime including antibonding VBM
- As a first test case, we synthesized Bil₃ [2] in two different vapor transport systems



- properties
- et al.. MRS Communications, 1-12 (2015). DOI: 10.1557/mrc.2015.26 R. E. Brandt, R. C. Kurchin, et al., J. Phys. Chem. Lett., 4297-4302 (2015). DOI: 10.1021/acs.jpclett.5b02022

Vapor Transport Growth Systems

Process parameters: temperature set point(s), substrate material, substrate position(s), N₂ flow rate, background pressure [grey text = parameter was not varied in this study]



- Allows "combinatorial" deposition across range of substrate temperatures
- Properties highly dependent on precise positioning of substrate



In both systems, high-temperature growth is limited by reevaporation. However, the reproducibility afforded by the two-zone apparatus makes it preferable overall.

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Next Steps

- way to quantify this!
- substrate choice are desirable to grow compact,
- determine optimum device architecture
- Make devices to measure I-V characteristics, QE, etc.

Conclusions & Acknowledgements

- in the resulting thin films
- future materials screening efforts

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We hypothesize that higher lifetimes are due to lower intragranular structural defect density – but we need a

Further experimentation with growth conditions and continuous films that would be appropriate for devices Measure band offsets and perform device modeling to

We designed a growth system and explored the effects of various process parameters on properties of interest

Best practices (primarily, to grow at highest achievable) deposition temperature) will be incorporated into

